

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Prior Application: K. ANAZAWA et al
Serial No. 10/078,347
Filed: February 21, 2002

Group Art Unit: 1754
Examiner: P. Lish
For: RADIOACTIVE SUBSTANCE DECONTAMINATION
METHOD AND APPARATUS

INFORMATION DISCLOSURE STATEMENT (IDS)
UNDER § 1.97 AND § 1.98

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450


March 24, 2004

Sir:

In accordance with the duty of disclosure, the Applicants inform the Examiner of the documents cited during prosecution of the parent application, USSN 10/078,347.

The Applicants request the Examiner to initial and return a copy of the attached PTO-1449 form as an indication that the references have been considered.

Respectfully submitted,



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Registration No. 32,846
Attorney for Applicant(s)

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Date: March 24, 2004

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIP-256-03		SERIAL NO.	
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT K. ANAZAWA et al			
				FILING DATE 03/24/04		GROUP 1754	
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>	
AA	4,690,782	09/1987	Lemmens				
AB							
AC							
AD							
AE							
AF							
AG							
AH							
AI							
AJ							
AK							
FOREIGN PATENT DOCUMENTS							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
AL	2000-105295	04/11/00	Japan			<input type="checkbox"/>	<input type="checkbox"/>
AM	09-510784	10/28/97	Japan			<input type="checkbox"/>	<input type="checkbox"/>
AN	95/26555	10/05/95	WIPO			<input type="checkbox"/>	<input type="checkbox"/>
AO	07-253496	10/03/95	Japan			<input type="checkbox"/>	<input type="checkbox"/>
AP	2000-346988	12/15/00	Japan			<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>							
	AR						
	AS						
	AT						
EXAMINER				DATE CONSIDERED			
<small>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AL 2001-74887	03/23/01	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>							
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